

<b>Notice of References Cited</b>	Application/Control No. 10/596,780	Applicant(s)/Patent Under Reexamination INOUE ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0165825 a1	11-2002	Matsushima et al.	705/51
*	B	US-2002/0067352 a1	06-2002	Takeuchi, Ryosuke	345/204
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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